

Notice of References Cited	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10/630,714	YOSHIDA, KEISUKE
	Examiner	Art Unit
	Pierre-Michel Bataille	2186
		Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-2003/0233385	12-2003	Srinivasa et al.	709/1
	C	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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